

<b>Notice of References Cited</b>	Application/Control No. 10/519,766		Applicant(s)/Patent Under Reexamination SCHULTHEIS ET AL.	
	Examiner DAVID BANH		Art Unit 2854	Page 1 of 1

#### U.S. PATENT DOCUMENTS

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*	B	US-2001/0050019 A1	12-2001	Ezaki et al.	101/488
*	C	US-2004/0011234 A1	01-2004	Figov et al.	101/488
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	K	US-			
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#### NON-PATENT DOCUMENTS

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